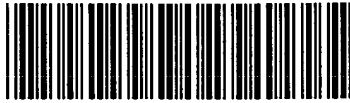


**Search Notes**

Application/Control No.

10/802,868

Examiner

Matthew G. Kayrish

Applicant(s)/Patent under  
Reexamination

IIDA, HIROYUKI

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
360	230	5/23/2006	MK
428	694	5/23/2006	MK
360	224	5/23/2006	MK
360	234	5/23/2006	MK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT) (See Attached Search History)	5/23/2006	MK
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT) (See Attached Search History)	5/24/2006	MK